

L Number	Hits	Search Text	DB	Time stamp
1	2	"20020118018"	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/12/12 15:58
-	6696	memory and (test or testing) near3 (clock or clk or timing)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/12/11 09:02
-	1182	memory and (test or testing) near3 mode near3 (clock or clk or timing)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/12/08 10:46
-	569	memory and (test or testing) near3 mode near3 (clock or clk or timing) and (word or digit or bit) near3 (line or conductor or wire or trace)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/12/08 10:48
-	172	memory and (test or testing) near5 (clock or clk or timing) near4 (frequency or exclusive\$3 or solely or separate or distinct) and (word or digit or bit) near3 (line or conductor or wire or trace)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/12/08 11:38
-	1327	memory and (test or testing) near2 (clock or clk or timing) and (word or digit or bit) near3 (line or conductor or wire or trace) and (address or addressing or select or selection)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/12/08 11:39
-	1149	memory and (test or testing) near2 (clock or clk or timing) and (word or digit or bit) near3 (line or conductor or wire or trace) and (address or addressing or select or selection) and (test or testing) near2 (mode or circuit or operation)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/12/08 11:40
-	613	memory and (test or testing) near2 (clock or clk or timing) and (word or digit or bit) near3 (line or conductor or wire or trace) and (address or addressing or select or selection) near3 (row or column) and (test or testing) near (mode or circuit or operation)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/12/08 11:42
-	22	memory and (test or testing) near4 (clock or clk or timing) near4 (low or lower or slow or different or distinct or smaller or small or slower or decreased or exclusive or exclusively) near3 (frequency or MHz or Hz or GHz or khz) and (word or digit or bit) near3 (line or conductor or wire or trace) and (address or addressing or select or selection) near3 (row or column) and (test or testing) near (mode or circuit or operation)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/12/08 11:43
-	1514	(RAS or CAS) near3 (test or testing)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/12/09 17:27
-	277	(RAS or CAS) near3 (test or testing) and memory and (clock or clk)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/12/09 17:27
-	156	(RAS or CAS) near3 (test or testing) and memory and (test or testing) near2 (clock or clk or timing)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/12/09 17:41

		2	(RAS or CAS) near3 (test or testing) and memory and (test or testing) near2 (clock or clk or timing) near8 (low or lower or slow or different or distinct or smaller or small or slower or decreased or exclusive or exclusively) near3 (frequency or speed or MHz or GHZ o khz)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/12/09 17:43
		12	(RAS or CAS) near5 (test or testing) and memory and (test or testing) near5 (clock or clk or timing) near5 (low or lower or slow or different or distinct or smaller or small or slower or decreased or exclusive or exclusively) near3 (frequency or speed or MHz or GHZ o khz)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/12/09 17:43
		333	(low or small or decreased or lower) near2 frequency near2 (test or testing) and (memory or rom or ram or eeprom)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/12/11 09:03
		26	(low or small or decreased or lower) near2 frequency near2 (test or testing) and (memory or rom or ram or eeprom) and clock and (pre adj charg\$3 or precharg\$3)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/12/11 09:11
		27	(low or small or decreased or lower) near (speed or frequency) near (test or testing or tester) and (memory or rom or ram or eeprom) and clock and (pre adj charg\$3 or precharg\$3)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/12/11 09:49
		2	6151272.pn.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/12/11 09:58
		2705	365/201.cccls.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/12/11 09:58
		434	365/201.cccls. and (testing or test or tester or error near2 detect\$3) near2 (clock or timing or (low or small) near2 (frequency or speed))	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/12/11 09:59
		188	365/201.cccls. and (testing or test or tester or error near2 detect\$3) near2 (clock or timing or (low or small) near2 (frequency or speed)) and (bit or word or column or row) and (precharg\$3 or pre adj charg\$3 or charg\$3)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/12/11 10:02
		45	365/201.cccls. and (low or small or slower or decreased or exclusive or varying) near2 (speed or frequency) near2 (clock or timing or clk or timer or signal) and (test or testing or (error or fault or bad) near2 (writing or write or bit or detect\$3))	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/12/11 10:11
		28	365/201.cccls. and (low or small or slower or decreased) near (speed or frequency) near (clock or timing or clk or timer or signal) and (test or testing or (error or fault or bad) near2 (writing or write or bit or detect\$3))	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/12/11 13:29
		156	365/201.cccls. and (test or testing) near (clock or clk)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/12/11 15:16
		2	6061285.pn.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/12/11 15:23

		3	("4608669" "5610867" "5619460").PN. 6061285.URPN. 5805514.pn.	USPAT USPAT USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB USPAT	2003/12/11 15:17 2003/12/11 15:19 2003/12/11 15:26
		5	("5181205" "5519659" "5625597" "5640354" "5640509").PN.	USPAT	2003/12/11 15:23
		2	5805514.URPN.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB USPAT;	2003/12/11 15:25 2003/12/11 15:28
		285	memory and (test or testing) near2 (clock or clk or frequency or timer) and cas and ras and bit and word	US-PGPUB; EPO; JPO; DERWENT; IBM_TDB USPAT;	2003/12/11 15:34
		285	memory and (test or testing) near2 (clock or clk or frequency or timer) and cas and ras and bit and word	US-PGPUB; EPO; JPO; DERWENT; IBM_TDB USPAT;	2003/12/11 15:34
		21	memory and (test or testing) near5 (low or slow or slower or decreased or lower) near2 (speed or frequency) near2 (clock or clk or timer or signal) and cas and ras and bit and word	US-PGPUB; EPO; JPO; DERWENT; IBM_TDB USPAT;	2003/12/11 15:52
		1251	memory and ras and cas and test adj mode	US-PGPUB; EPO; JPO; DERWENT; IBM_TDB USPAT;	2003/12/11 16:00
		494	memory and (test or testing or inspecting or inspect or inspection or measure or measurement) near5 (write or writing or bit) near3 (failure or fail or fault or failed or error or bad) and (precharg\$3 or pre adj charg\$3 or charg\$3)	US-PGPUB; EPO; JPO; DERWENT; IBM_TDB USPAT;	2003/12/11 16:02
		0	memory and (test or testing or inspecting or inspect or inspection or measure or measurement) near5 (write or writing or bit) near3 (failure or fail or fault or failed or error or bad) and (precharg\$3 or pre adj charg\$3 or charg\$3) and (test or testing or inspection or inspecting or inspect) near (mode or clock or signal or waveform or pattern or flag)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/12/11 16:07
		277	memory and (test or testing or inspecting or inspect or inspection or measure or measurement) near5 (write or writing or bit) near3 (failure or fail or fault or failed or error or bad) and (precharg\$3 or pre adj charg\$3 or charg\$3) and (test or testing or inspection or inspecting or inspect) near (mode or clock or signal or waveform or pattern or flag)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/12/11 16:07
		39	memory and (test or testing or inspecting or inspect or inspection or measure or measurement) near5 (write or writing or bit) near3 (failure or fail or fault or failed or error or bad) and (precharg\$3 or pre adj charg\$3 or charg\$3) and (test or testing or inspection or inspecting or inspect) near (mode or clock or signal or waveform or pattern or flag) and (testing or tester or clock or clk or inspection or inspector or inspecting) near2 (low or high or lower or higher or small or large) near2 (speed or frequency)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/12/11 16:31
		894	memory and test adj mode and (test or testing) adj clock	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/12/11 16:32

	20	memory and test adj mode and (test or testing) adj clock near6 (low or lower or slow or reduced or small or decreased) near2 (speed or frequency)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/12/11 16:44
	0	memory and test adj mode and (test or testing) adj clock near8 (write or writing) near2 (error or erroneous or failure or fault or failed)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/12/11 16:43
	0	memory and test adj mode and (test or testing) adj clock near10 (write or writing) near3(error or erroneous or failure or fault or failed)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/12/11 16:43
	0	memory and test adj mode with clock with (write or writing) near3(error or erroneous or failure or fault or failed)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/12/11 16:44
	0	memory and (test or testing) near3 clock with (write or writing) near3 (error or erroneous or failure or fault or failed)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/12/11 16:44
	10	memory and (test or testing) near3 clock same (write or writing) near3 (error or erroneous or failure or fault or failed)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/12/11 16:46
	637	365/185.23.ccls.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/12/11 16:46
	51	365/185.23.ccls. and (test or testing) near3 (mode or clock or clk or timing)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/12/11 16:51
	12	365/185.25.ccls. and (test or testing) near3 (mode or clock or clk or timing)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/12/11 17:11
	486	365/200.ccls. and (test or testing) near3 (mode or clock or clk or timing)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/12/11 16:53
	338	365/200.ccls. and (test or testing) near (mode or clock or clk or timing) and bit and word and (select or selecting or selection or address or addressing or ras or cas)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/12/11 16:53
	21	365/200.ccls. and (test or testing) near (clock or clk) and bit and word and (select or selecting or selection or address or addressing or ras or cas)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/12/11 17:03
	5	365/203.ccls. and (test or testing) near (clock or clk) and bit and word and (select or selecting or selection or address or addressing or ras or cas)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/12/11 17:11
	9	("5432747" "5471430" "5886946" "5905690" "5963497" "6061285" "6061294" "6108248" "6185141").PN.	USPAT	2003/12/11 17:04

	1	365/210.cccls. and (test or testing) near (clock or clk) and bit and word and (select or selecting or selection or address or addressing or ras or cas)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/12/11 17:28
	74	365/210.cccls. and (test or testing) near3 (mode or clock or clk or timing)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/12/11 17:12
	54	365/210.cccls. and (test or testing) near3 (mode or clock or clk or timing) and bit and word	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/12/11 17:27
	202	365/233.cccls. and (test or testing) near3 (mode or clock or clk or timing) and bit and word	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/12/11 17:27
	46	365/233.cccls. and (test or testing) near (clock or clk) and bit and word and (select or selecting or selection or address or addressing or ras or cas)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/12/11 17:28
	203	365/201.cccls. and ((internal or i) near2 (ras or ra or cas or ca or row adj access or strobe or row adj address\$3 or column adj access or column adj address\$3) or rasi or casi or iras or icas) and ((external or signal or e) near2 (ras or ra or cas or ca or row adj access or strobe or row adj address\$3 or column adj access or column adj address\$3) or rase or eras or case or ecas)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/12/12 09:55
	193	365/201.cccls. and ((internal or i) near2 (ras or ra or cas or ca or row adj access or strobe or row adj address\$3 or column adj access or column adj address\$3) or rasi or casi or iras or icas) and ((external or signal or e) near2 (ras or ra or cas or ca or row adj access or strobe or row adj address\$3 or column adj access or column adj address\$3) or rase or eras or case or ecas) and (test or testing or low adj frequency or low adj speed or long adj cycle)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/12/12 12:59
	9	365/201.cccls. and ((internal or i) near2 (ras or ra or cas or ca or row adj access or strobe or row adj address\$3 or column adj access or column adj address\$3) or rasi or casi or iras or icas) near10 (clock or clk or timing) near10 (test or testing)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/12/12 13:03
	242	365/201.cccls. and test near3 (clock or clk or timing or signal or pattern or waveform) near4 (speed or frequency or cycle)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/12/12 13:04
	234	365/201.cccls. and test near3 (clock or clk or timing or signal or pattern or waveform) near4 (speed or frequency or cycle) and (address or addressing or select or selection or selecting or ras or cas)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/12/12 13:06
	257	365/201.cccls. and (test or testing or tester) near3 (clock or clk or timing or signal or pattern or waveform) near4 (speed or frequency or cycle) and (address or addressing or select or selection or selecting or ras or cas)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/12/12 13:06

	32	365/201.cccls. and (test or testing or tester) near3 (clock or clk or timing or signal or pattern or waveform) near4 (speed or frequency or cycle) near2 (low or long or small) and (address or addressing or select or selection or selecting or ras or cas)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/12/12 13:18
	84	365/\$.cccls. and (long adj cycle or low adj speed or low adj frequency) near2 (testing or tester or test)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/12/12 13:36
	39	365/\$.cccls. and (rasi or internal adj ras or iras) near6 (clock or clk) near6 (external adj ras or rase or ras or eras)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/12/12 13:56
	21	(US-6091651-\$ or US-6489819-\$ or US-6545910-\$ or US-6297997-\$ or US-6532184-\$ or US-6269036-\$ or US-6522598-\$ or US-6519194-\$ or US-6643203-\$ or US-6252820-\$ or US-5991214-\$ or US-5973990-\$ or US-5892776-\$ or US-6208583-\$ or US-5335202-\$ or US-4779164-\$ or US-6408411-\$ or US-6215712-\$ or US-6034904-\$).did. or (US-20020167859-\$ or US-20020080668-\$).did.	USPAT; US-PGPUB	2003/12/12 13:53
	496	365/\$.cccls. and (test or testing or measuring or inspecting or inspection or detecting or detection) near3 (short or shorted or shorting)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/12/12 13:58
	71	365/\$.cccls. and (test or testing or measuring or inspecting or inspection or detecting or detection) near2 (short or shorted or shorting) and (test or testing or inspection or inspecting or detection) near3 (timing or clock or clk)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/12/12 14:00
	26	365/\$.cccls. and (test or testing or measuring or inspecting or inspection or detecting or detection) near2 (short or shorted or shorting) and (testing or timing or inspection or inspecting or detection or detecting) near3 (speed or frequency or cycle) near3 (low or long or slow or slower or lower or longer or high or fast or faster or short or shorter)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/12/12 14:22
	98	438/11.cccls.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/12/12 14:22
	98	438/11.cccls.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/12/12 14:24
	86	438/12.cccls.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/12/12 15:58